Voltage-biased I-V characteristics in the multiple Josephson junction model of high-Tc superconductors

<table>
<thead>
<tr>
<th>著者</th>
<th>サカモト 修一, 松本 英樹, 小山 友雄, 門田 雅彦</th>
</tr>
</thead>
<tbody>
<tr>
<td>種類</td>
<td>物理</td>
</tr>
<tr>
<td>巻</td>
<td>61</td>
</tr>
<tr>
<td>号</td>
<td>5</td>
</tr>
<tr>
<td>頁</td>
<td>3707-3710</td>
</tr>
<tr>
<td>年</td>
<td>2000</td>
</tr>
<tr>
<td>URL</td>
<td><a href="http://hdl.handle.net/10097/53280">http://hdl.handle.net/10097/53280</a></td>
</tr>
<tr>
<td>doi</td>
<td>10.1103/PhysRevB.61.3707</td>
</tr>
</tbody>
</table>
Voltage-biased $I$-$V$ characteristics in the multiple Josephson junction model of high-$T_c$ superconductors

Shoichi Sakamoto and Hideki Matsumoto
Department of Applied Physics, Seikei University, Kichijoji Kitamachi 3-3-1, Musashino-shi 180-8633, Japan

Tomio Koyama
Institute for Materials Research, Tohoku University, Katahira 2-1-1, Sendai 980, Japan

Masahiko Machida
Center for Promotion of Computational Science and Engineering, Japan Atomic Research Institute, 2-2-54 Nakameguro, Meguro-ku, Tokyo 153, Japan
(Received 6 May 1999)

By use of the multiple Josephson junction model, we investigate voltage-biased $I$-$V$ characteristics by numerical simulation. We show that there exist three characteristic regions in the $I$-$V$ curve. In the low voltage region, the total current is periodic with trigonometric functional increases and rapid drops. Then a kind of chaotic region follows. Above a certain voltage, the total current behaves with a simple harmonic oscillation and the $I$-$V$ characteristics form a multiple branch structure as in the current-biased case.

$I$-$V$ characteristics of the high-$T_c$ superconductor $\text{Bi}_2\text{Sr}_2\text{Ca}_1\text{Cu}_2\text{O}_8$ (BSCCO) shows a strong hysteresis, producing multiple branches.\(^1-^3\) Many experiments have been reported to investigate properties of hysteresis branches,\(^4-10\) and it has turned out that there is rich physics in properties of $I$-$V$ characteristics. Substructures are found in hysteresis branches, and are discussed in relation with phonon effects.\(^3\) The $d$-wave effect is also discussed in the higher voltage region, where the tunneling current becomes important.\(^6,10\)

It is well known in a single Josephson junction that the application of a constant voltage bias leads a rather simple phenomenon of the harmonic current oscillation with the frequency proportional to the applied voltage.\(^11\) This is due to the fact that the time derivative of the phase difference is directly connected with the voltage, and that there is no room for the phase to move freely. Therefore, most of the above-mentioned experiments were performed with the current-biased arrangement, aiming to investigate properties of $I$-$V$ hysteresis branches, and, as far as we know, no systematic experiment with the voltage bias has been reported. We will point out in this paper that anomalous behaviors are expected, theoretically, in the low voltage-biased region in the case of the multiple layered intrinsic Josephson junctions of high-$T_c$ superconductors, and that the voltage-biased experiment gives additional information on behaviors of $I$-$V$ characteristics.

In the multiple layered intrinsic Josephson junctions of high-$T_c$ superconductors, interlayer couplings among superconducting phase differences become important due to the atomic scale of the thickness of the superconducting layer. In Ref. 12 the mechanism of the interlayer coupling is proposed as the charging effect of superconducting layers; the charging effect induces the variation of electric field and mediates the interlayer coupling among superconducting phase differences. It has been shown that, by this mechanism, a branch structure in the $I$-$V$ characteristics is obtained as the intrinsic nature of the strong anisotropy of high-$T_c$ superconductors.\(^13\) In the previous paper,\(^14\) we have investigated the origin of hysteresis branches, and have shown that hysteresis branches are induced when solutions change in nonlinear-coupled equations of phase differences. Namely, the number of rotating phases and its patterns classifies solutions. At a point of a hysteresis jump, its number or distribution pattern is changed.

The main difference between the cases of the single junction and the multiple junction lies in the fact that the applied voltage gives restriction only on the total voltage. Therefore, each junction may behave in a self-adjusted way, if an interaction effect allows it. In a simple array of $N$ single junctions, each junction feels only the $N$th of the applied voltage, and one cannot expect much difference from the case of the single junction. However, in the intrinsic Josephson array of the high-$T_c$ superconductors, the existence of an interlayer coupling affects the collective motion of phase differences. Furthermore, the voltage control and current control lead to different situations. Especially, in the voltage control case, one can reach transient unstable states of the current-biased case, since the applied voltage still enforces the total behavior of phase differences.

In this paper, we investigate $I$-$V$ characteristics in voltage-biased cases of high-$T_c$ superconductors. Since there is no experiment available to refer to at present, several cases with possible surface conditions will be presented. It will be shown that certain anomalous behavior of $I$-$V$ characteristics appears in the applied low voltage region. We show that the voltage region is divided roughly into three regions, an anomalous periodic region, a chaotic region, and a region of hysteresis branches. In an anomalous periodic region, the current shows a trigonometric functional increase and rapid drop. In a chaotic region, the total current behaves chaotically. In the last region, the behavior of the current is quasi-harmonic. The physical origin of these regions will be discussed.
We rewrite the formula for the multiple Josephson junction of Ref. 14 suitable to the voltage-biased analysis. The notations used here are same as those in Ref. 14. Namely, we consider the \( N + 1 \) superconducting layers, numbered from 0 to \( N \). We denote the gauge invariant phase difference of the \((l-1)\)th and \(l\)th superconducting layer by \( \varphi(l) \), and voltage by \( V(l) \). The widths of the insulating and superconducting layers are denoted by \( D \) and \( s \), respectively. At the edges, the effective width of the superconducting layer may be extended due to the proximity effect into attached lead metals. The widths of the 0th and \( N \)th superconducting layers are denoted by \( s_0 \) and \( s_N \), respectively.

In the voltage-biased case, the total voltage is equal to the applied external voltage \( V_{\text{ext}} \), \( V_{\text{ext}} = \sum_{l=1}^{N} V_l \). In order to perform a numerical simulation under this condition, we rewrite the equation for the total current \( J \) [Eq. (1) in Ref. 14] and the equation relating the time derivative of the phase difference and voltage [Eq. (3) in Ref. 14] in the following way. First, we note that the total current \( J \) is expressed by the external voltage \( V_{\text{ext}} \) as

\[
\frac{J}{J_c} = \frac{1}{N} \left( \sum_{l=1}^{N} j_c(l) \sin(\varphi(l)) + \beta \frac{V_{\text{ext}}}{V_p} + \frac{1}{\omega_p} \frac{\partial}{\partial t} \frac{V_{\text{ext}}}{V_p} \right). \tag{1}
\]

The current \( J \) is normalized by the critical current \( J_c \), \( j_c(l) = J_c(l)/J_c \) with \( J_c(l) \) being the critical current for the \( l \)th junction. The time \( t \) is normalized by the inverse of the plasma frequency, \( \omega_p = \sqrt{(2e/\hbar)(4\pi D J_c)/\varepsilon} \), with \( \varepsilon \) being the dielectric constant of the insulating layer. The voltage \( V(l) \) is normalized by \( V_p = \hbar \omega_p / 2e \). The parameter \( \beta \) is given by \( \beta = \sigma V_p / J_c D \). We define the voltage difference \( \nu(l) \) as \( V(l) = (V_{\text{ext}}/N) + \nu(l) \). Then we have the following coupled differential equations,

\[
\frac{1}{\omega_p} \frac{\partial}{\partial t} \frac{\nu(l)}{V_p} = -\beta \frac{\nu(l)}{V_p} - j_c(l) \sin(\varphi(l)) + \frac{1}{N} \sum_{l'=1}^{N} j_c(l') \sin(\varphi(l')) \tag{2}
\]

and

\[
\frac{1}{\omega_p} \frac{\partial}{\partial t} \varphi(l) = \sum_{l'=1}^{N} A_{ll'} \left( \frac{1}{N} \frac{V_{\text{ext}}}{V_p} + \frac{\nu(l')}{V_p} \right). \tag{3}
\]

A dissipation effect\textsuperscript{14–16} in superconducting layers will be neglected in this paper, and the matrix \( A \) is given in Eq. (4) in Ref. 14. It should be noted that Eq. (2) gives \((1/\omega_p)(\partial V_{\text{ext}}) / \partial t) = 0 \) at the initial time, it is satisfied in all time. In the following, we present results of solving Eqs. (2) and (3) by numerical simulation. The restriction from the total voltage is achieved by putting the initial condition \( \sum_{l=1}^{N} V(l) = 0 \). The equation for \( \nu(l) \), Eq. (3), indicates that the phase differences move according to \((1/N) V_{\text{ext}} \) as average. However, due to the mutual interaction, each \( \varphi(l) \) shows a complicated behavior which affects the \( I-V \) characteristics and the behavior of the total current.

We have solved the coupled differential equations (2) and (3) by use of the fourth order Runge-Kutta method. The average current \( J \) is obtained by

\[
J = \left[ \frac{1}{T_{\text{max}} - T_{\text{min}}} \int_{T_{\text{min}}}^{T_{\text{max}}} \frac{\partial}{\partial t} J(t) \right].
\]

We choose the parameters as \( N = 10, \alpha = 1.0, \beta = 0.2 \), which have been used in Ref. 14. In the simulation we have chosen the time step \( \omega_p dt = 1.0 \times 10^{-3} \), \( \omega_p T_{\text{min}} = 10.0 \), \( \beta \omega_p T_{\text{max}} = 310.0 \), and the voltage step \( dV_{\text{ext}} = 0.01 \).

As Eq. (3) shows, the phase \( \varphi(l) \) increases according to \( \int dt (1/N) V_{\text{ext}} \) when \( V_{\text{ext}} \) is small. When \( \varphi(l) \) reaches the value \( \pi/2 \), the phase goes into a rotating mode as can be seen from the analogy of the motion of a pendulum with a \( \sin(\varphi(l)) \)-nonlinear term. This indicates that the whole motions of phases \( \varphi(l) \) are much affected by the phase with the lowest \( j_c \).

It may be difficult to arrange two electrodes at edges exactly in the same condition. However, in order to show how surface conditions affect the behavior of \( I-V \) characteristics, we present the following three cases: (1) \( j_c(l) \) are symmetric but widths of surface are asymmetric, (2) both \( j_c(l) \) and widths of surface are symmetric, and (3) \( j_c(l) \) are asymmetric and widths of surface are symmetric. The case with \( j_c(l) \) asymmetric and widths of surface asymmetric shows similar behavior as case (3). It should be noted that, even if the asymmetry between \( s_0 \) and \( s_N \) is introduced, the observed critical current is \( j_c \) in the current-biased case.

We first assume that all \( j_c(l) \) are equal, \( j_c(l) = 1.0 \), and choose, for example, an asymmetric boundary condition \( s_0/s = 1.0 \) and \( s_N/s = 2.0 \). In the present analysis, it is enough to have a slight difference between \( s_0 \) and \( s_N \), the difference of proximity effect.

In Fig. 1(a), we show the overall behavior of \( I-V \) characteristics obtained from the adiabatic increase and decrease of the applied voltage (circle points) and those obtained from...
abrupt application of the voltage (× points). We can see that the I-V characteristics show many hysteresis jumps, forming a branch structure. In the abrupt application of voltage, the data points in the low voltage region are scattered, although they lie on some linear I-V branches. Each I-V branch is classified by a number and pattern of rotating phases. When the voltage is large enough, all junctions have the rotating phase and the single I-V characteristic is obtained. In Fig. 1(a), we notice that there exists the region where the adiabatic and abrupt applications of voltage give the same results, in the low voltage region before the branch structure starts. In Fig. 1(b), we expand the low voltage region. We can identify the obvious branches labeled as I1, I2, II, III1, and III2. The crosses (×) are for the abrupt voltage application. Lines I and II are the same for the three cases of the adiabatic increase, decrease, and abrupt application of the voltage. The branches III1 and III2 are linear. The calculation shows that the I-V relations for III1 and III2 are same as those obtained from the hysteresis branches in the I-V characteristics of the current-biased case. On line III1, the phase \( \varphi (1) \) is rotating and on line III2 the phases \( \varphi (1) \) and \( \varphi (N) \) are rotating. Other phases \( \varphi (l) \) are oscillating. The cross points are grouped as one-rotating phase and two-rotating phase. The scattered points are identified by the distribution of the rotating phases among \( N \) junctions.

In Fig. 2(a), we show the I-V characteristics, when we choose a symmetric boundary condition \( s_0 / s = 1.0 \) and \( s_N / s = 1.0 \). The branch II in Fig. 1 is separated into II1 and II2. The branch III2 is linear and is exactly the same line as III2 in Fig. 1. Although the branch II2 is linear and lies on the same line as III1, the calculated points are largely scattered, indicating a certain kind of instability. In order to obtain Fig. 2(a), we have to ensure the symmetry, \( \varphi (l) = \varphi (N+1-l) \), \( V(l) = V(N+1-l) \), in each time step by taking the average of \( \varphi (l) \) and \( \varphi (N+1-l) \), for example. Otherwise, a very small round error rapidly develops in region II, and we obtained the similar result of Fig. 1(b), although we start with the symmetric boundary condition.

In order to see what kinds of solutions are realized in regions I and II, we plot, in Figs. 2(b)−2(e), the time dependence of phase \( \varphi (l) \) and current \( J \) for the case of Fig. 2(a). Figures 2(b) and 2(c) are for branches I1 and II, and Figs. 2(d) and 2(e) are for II1. Figure 2(c) shows periodic current behaviors, while Fig. 2(e) shows chaotic current behaviors. The results show the following. All \( \varphi (l) \) increase slowly in the same way according to the applied voltage. When \( \varphi (1) \) and \( \varphi (N) \) at the edges reach the value \( \pi /2 \), they increase rapidly in the phase-rotating mode. Other \( \varphi (l) \)'s swing back. The phases \( \varphi (1) \) and \( \varphi (N) \) damp their motion by the effect of resistance \( \beta \), and move slowly again in the same way as the other phases. As the result, the current behaves periodically with trigonometric functional increase and rapid drop. Regions I1 and I2 are different in the values of phase rotation, 2\( \pi \) and 4\( \pi \), before damping. In Fig. 2(d), not only the phases at the edges but also other phases \( \varphi (l) \) go into the rotating mode. Since oscillation and rotation of phases are interface in a complicated way, the chaotic current behavior is produced. Regions II1 and II2 are different in the values of phase rotation, 2\( \pi \) and 4\( \pi \), at the edges.

The above results lead us to the following understanding of solutions of the multiple Josephson junction in the voltage-biased case. The applied voltage \( V_{ext} \) forces the phase-differences \( \varphi (l) \) of junctions to rotate. When some \( \varphi (l) \) reaches \( \pi /2 \), it goes into the natural rotating mode with other phases swinging back. How much it rotates depends on its speed and resistance, forming new non-Ohmic branches. When the rotation and oscillation of phase differences start to interact, solutions go into a chaotic region. When the voltage becomes large enough for certain phase differences to keep rotating, the I-V characteristics become Ohmic and form multiple branches.

From the above understanding, we can immediately see that the I-V characteristics may change when there exists a certain junction with weaker \( j_e \). Most likely, the surface layers may be damaged in the preparation process of elec-
the external voltage (1/N) V_{ext}, there is still room for each phase to move self-consistently according to the interaction. Therefore, when the voltage is low, there is a competition of the voltage forced motion and the motion induced by the interactions. Adiabatic increase of the external voltage induces the following successive transition. In the low voltage, one has the region with a periodic oscillatory current of an asymmetric wave form, and then a possible region with a chaotic current oscillation follows. In these regions, non-Ohmic branches are formed. In higher voltage, the region with a stable harmonic oscillatory current appears, having Ohmic I-V branches. When there is a junction with a weaker J_c, it is easier for the associated phase difference to go into the rotating mode. Then the I-V characteristics have a quasiperiodic behavior in its non-Ohmic region. The present analysis shows that voltage-biased J-V characteristics reveal the importance of interlayer coupling more strongly, and give additional information on the current-biased case.

This work was supported by the Special Research Grant in the Faculty of Engineering, Seikei University (H.M. and S.S.), and Grant-in-Aid for Scientific Research (C) from Japan Society for the Promotion of Science (T.K.).